


<b>Search Notes</b> 	<b>Application/Control No.</b> 10582000	<b>Applicant(s)/Patent Under Reexamination</b> INOUE ET AL.
	<b>Examiner</b> Heincer, Liam J	<b>Art Unit</b> 1709

### SEARCHED

Class	Subclass	Date	Examiner
525	237	9/10/07	LH

### SEARCH NOTES

Search Notes	Date	Examiner
EAST Search (USPAT, USPGPub, USOCR, EPO, JPO, DERWENT) see search report	9/10/07	LH
Inventor Name Search	9/10/07	LH
PLUS Search	9/6/07	LH
Updated EAST Search (USPAT, USPGPub, USOCR, EPO, JPO, DERWENT) see search report	2/28/08	LH
Updated EAST Search (USPAT, USPGPub, USOCR, EPO, JPO, DERWENT) see search report	10/9/08	LH
Updated EAST Search (USPAT, USPGPub, USOCR, EPO, JPO, DERWENT) see search report	4/27/09	LH
Updated EAST Search (USPAT, USPGPub, USOCR, EPO, JPO, DERWENT) see search report	12/23/2009	LH
Updated EAST Search (USPAT, USPGPub, USOCR, EPO, JPO, DERWENT) see search report	6/16/2010	LH
Updated EAST Search (USPAT, USPGPub, USOCR, EPO, JPO, DERWENT) see search report	12/3/2010	LH
Updated EAST Search (USPAT, USPGPub, USOCR, EPO, JPO, DERWENT) see search report	7/25/2011	LH

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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